


<div style="display: flex; justify-content: space-around; align-items: center;"> <div style="text-align: center;">  <p>LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)</p> </div> <div> <p>ATTY. DOCKET NO. P-0339</p> <p>APPLICANT(S) Kwang Shin JUNG</p> <p>CUSTOMER NO. 34610</p> <p>FILING DATE March 7, 2002</p> </div> <div> <p>APPLN. SERIAL NO. 10/091,491</p> <p>GROUP 2811</p> </div> </div>							
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
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FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
WH	JP 06-224816	08/12/1994	Japan (English Abstract only)(Full Text in Japanese)			X	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)							
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